



Docket No. 29273/317

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

APPLICANTS

Kazumichi IMAI et al.

SERIAL NO.

(Cont. of 09/852,269)

FILED

(Herewith)

FOR

ELECTROPHORESIS ANALYSIS APPARATUS

AND SAMPLE VESSEL USED THEREFOR

GROUP ART

1744 (Anticipated)

EXAMINER

A. Aldag (Anticipated)

COMMISSIONER FOR PATENTS

P. O. Box 1450.

Alexandria, Virginia 22313-1450

INFORMATION DISCLOSURE STATEMENT UNDER 37 C.F.R. § 1.97 & § 1.98

SIR:

In conformance with Applicants' duty of disclosure under 37 C.F.R. § 1.56 and § 1.97(b)(1), the references listed on the attached form PTO-1449 are hereby brought to the Examiner's attention.

Since all of the references have already been considered by the Examiner in parent application Serial No. 09/852,269, no copies of the references are required.

It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the references be made of record therein and appear in the "references cited" on any patent to issue therefrom.

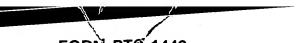
Respectfully submitted,

Dated: 26 February 2004

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Sheet 1 of 1

FORM PTO-1449 **INFORMATION DISCLOSURE STATEMENT BY APPLICANT(S)**

Atty Docket No.

: 29273/317

Serial No. **Applicants**

: K. IMAI et al.

Filed

: (Herewith)

Group Art Unit

Examiner

U.S. PATENT DOCUMENTS

Examiner Initial	Patent <u>Number</u>	Patent <u>Date</u>	<u>Name</u>	Class/ Subclass	Filing <u>Date</u>
	5,916,428 5,885,430 5,730,850 5,585,069 5,541,420 5,439,578 5,413,686 5,384,024 5,372,695 5,366,608 5,277,780 5,274,240	05/29/99 03/23/99 03/24/98 12/17/96 07/30/96 08/08/95 05/09/95 01/24/95 12/13/94 11/22/94 01/11/94 12/28/93	KANE et al. KERNAN et al. KAMBARA et al. ZANZUCCHI et al. KAMBARA DOVICHI et al. KLEIN et al. MORING et al. DEMOREST KAMBARA KAMBARA MATHIES et al.	204/601 204/453 204/603 204/602 204/603 204/603 204/604 204/603 204/299 204/299 250/458	
FOREIGN PATENT DOCUMENTS					
. Examiner Initial	Document <u>Number</u>	<u>Date</u>	Clas Country Subcl		slation <u>No</u>
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)					
Examiner Initial					
	1. JANSSON et al.: Micro vials on a silicon wafer for sample introduction in capillary electrophoresis, J. Chromatog., 626, pp. 310-314, 1992				
EXAMINER	DATE CONSIDERED				
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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.